#### MITSUBISHI LSIs

# M5M5Y816WG -55HI, -70HI, -85HI

8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM

Those are summarized in the part name table below.

#### DESCRIPTION

The M5M5Y816 is a family of low voltage 8-Mbit static RAMs organized as 524288-words by 16-bit, fabricated by Mitsubishi's high-performance  $0.18\mu m$  CMOS technology.

The M5M5Y816 is suitable for memory applications where a simple interfacing , battery operating and battery backup are the important design objectives.

M5M5Y816WG is packaged in a CSP (chip scale package), with the outline of 7.5mm x 8.5mm, ball matrix of 6 x 8 (48ball) and ball pitch of 0.75mm. It gives the best solution for a compaction

of mounting area as well as flexibility of wiring pattern of printed circuit boards.

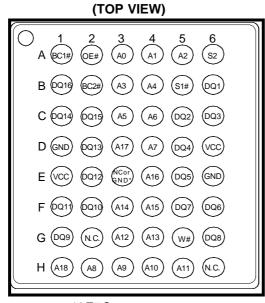
#### **FEATURES**

- Single 1.65~2.3V power supply
- Small stand-by current: 0.2µA (2.3V, typ.)
- No clocks, No refresh
- Data retention supply voltage =1.3V
- All inputs and outputs are TTL compatible.
- Easy memory expansion by S1#, S2, BC1# and BC2# - Common Data I/O
- Three-state outputs: OR-tie capability
- OE prevents data contention in the I/O bus
- Process technology: 0.18µm CMOS
- Package: 48ball 7.5mm x 8.5mm CSP

Version,					Sta	nd-by	current	: (µA)		Activ e
Operating temperature	Part name	Power A Supply	Access time max.	* Typical		F	Ratings (max.)			current Icc1
				25°C	40°C	25°C	40°C	70°C	85°C	(2.3V, max)
I-version	M5M5Y816WG -55HI	1.65 ~ 2.3V	55ns							30mA
-40 ~ +85°C	M5M5Y816WG -70HI	1.65 ~ 2.3V	70ns	0.2	0.4	2	4	15	30	(10MHz) 3mA
	M5M5Y816WG -85HI	1.65 ~ 2.3V	85ns							(1MHz)

Typical parameter indicates the value for the center of distribution at 2.3V, and not 100% tested.

#### **PIN CONFIGURATION**



Pin	Function
A0 ~ A18	Address input
DQ1 ~ DQ16	Data input / output
S1#	Chip select input 1
S2	Chip select input 2
W#	Write control input
OE	Output enable input
BC1#	Lower Byte (DQ1 ~ 8)
BC2#	Upper Byte (DQ9~16)
Vcc	Power supply
GND	Ground supply

Outline: 48F7Q

NC: No Connection

\*Don't connect E3 ball to voltage level more than 0V



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#### **FUNCTION**

The M5M5Y816WG is organized as 524288-words by 16-bit. These devices operate on a single +1.65~2.3V power supply, and are directly TTL compatible to both input and output. Its fully static circuit needs no clocks and no refresh, and makes it useful.

The operation mode are determined by a combination of the device control inputs BC1# , BC2# , S1#, S2 , W# and OE#. Each mode is summarized in the function table.

A write operation is executed whenever the low level W overlaps with the low level BC1# and/or BC2# and the low level S1# and the high level S2. The address(A0~A18) must be set up before the write cycle and must be stable during the entire cycle.

A read operation is executed by setting W# at a high level and OE# at a low level while BC1# and/or BC2# and S1# and S2 are in an active state(S1#=L,S2=H).

When setting BC1# at the high level and other pins are in an active stage, upper-byte are in a selectable mode in which both reading and writing are enabled, and lower-byte are in a non-selectable mode. And when setting BC2# at a high level and other pins are in an active stage, lower-byte are in a selectable mode and upper-byte are in a non-selectable mode.

#### **BLOCK DIAGRAM**

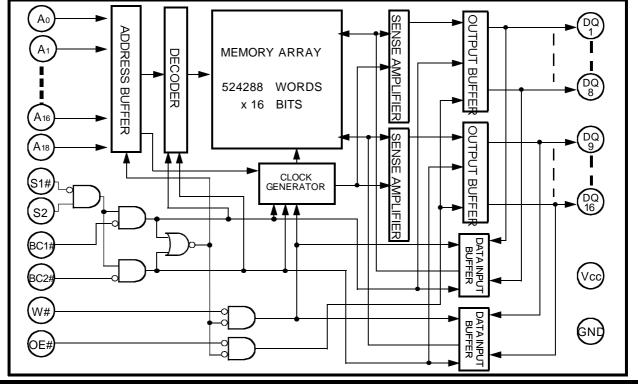
When setting BC1# and BC2# at a high level or S1# at a high level or S2 at a low level, the chips are in a non-selectable mode in which both reading and writing are disabled. In this mode, the output stage is in a high-impedance state, allowing OR-tie with other chips and memory expansion by BC1#, BC2# and S1#, S2.

The power supply current is reduced as low as  $0.1\mu A(25^{\circ}C, Vcc=1.65V, typical)$ , and the memory data can be held at +1.3V power supply, enabling battery back-up operation during power failure or power-down operation in the non-selected mode.

FUNCTION TABLE
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S1#	S2	BC1#	BC2#	W#	OE#	Mode	DQ1~8	DQ9~16	lcc
Н	L	Х	Х	Х	Х	Non selection	High-Z	High-Z	Standby
L	Ц	Х	Х	Х	Х	Non selection	High-Z	High-Z	Standby
Н	Н	Х	Х	Х	Х	Non selection	High-Z	High-Z	Standby
Х	Х	Н	Н	Х	Х	Non selection	High-Z	High-Z	Standby
L	Η	L	Н	L	Х	Write	Din	High-Z	Active
L	Η	L	Н	Н	L	Read	Dout	High-Z	Active
L	Η	L	Н	Н	Н		High-Z	High-Z	Active
L	Η	Н	L	L	Х	Write	High-Z	Din	Active
L	Η	Н	L	Н	L	Read	High-Z	Dout	Active
L	Η	Н	L	Η	Н		High-Z	High-Z	Active
L	Η	L	L	L	Х	Write	Din	Din	Active
L	Н	L	L	Н	L	Read	Dout	Dout	Activ e
L	Н	L	L	Н	Н		High-Z	High-Z	Active

note1: "H" and "L" in this table mean VIH and VIL, respectively . note2: "X" in this table should be "H" or "L".





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### ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Conditions	Ratings	Units
Vcc	Supply voltage	With respect to GND	-0.3* ~ +2.7	
Vı	Input voltage	With respect to GND	-0.3* ~ Vcc + 0.3 (max. 2.7V)	V
Vo	Output voltage	With respect to GND	0 ~ Vcc	
Pd	Power dissipation	Ta=25°C	700	mW
Ta	Operating temperature	I-v ersion	- 40 ~ +85	°C
Tstg	Storage temperature		- 65 ~ +150	°C

\* -0.7V in case of AC (Pulse width  $\leq$  30ns)

### DC ELECTRICAL CHARACTERISTICS

(Vcc=1.65~ 2.3V, unless otherwise noted)

					Limits		
Symbol	Parameter	Conditions		Min	Тур	Max	Units
Vih	High-lev el input voltage			0.7xVcc		Vcc+0.2	
VIL	Low-lev el input voltage			-0.2 *		0.4	
Vон	High-level output voltage	Iон= -0.1mA		1.3			V
Vol	Low-lev el output voltage	IoL=0.1mA				0.2	
h	Input leakage current	VI =0 ~ Vcc				±1	
lo	Output leakage current	C1# and BC2#=VIH or S1#=VIH or S2=VIL or OE#=VIH, VI/O=0 ~				±1	μA
lcc1	Active supply current	BC1# and BC2# 0.2V, S1# 0.2V, S2 Vcc-0.2V	f= 10MHz	-	20	30	
ICCT	(AC,MOS level)	other inputs ≦0.2V or ≧ Vcc-0.2V Output - open (duty 100%) f =	f= 1MHz	-	1.5	3	
	Active supply current	BC1# and BC2#=VIL , S1#=VIL ,S2=VIH other pins =VIH or VIL	f= 10MHz	-	20	30	mA
lcc2	(AC,TTL level)	Output - open (duty 100%)	f= 1MHz	-	1.5	3	
		(1) S1# ≥ Vcc - 0.2V, S2 ≥ Vcc - 0.2V,	~ +25°C	-	0.2	2	
lcc3	Stand by supply current	other inputs = 0 ~ Vcc (2) S2 $\leq$ 0.2V,	~ +40°C	-	0.4	4	
1003	( AC,MOS level )	other inputs = 0 ~ Vcc (3) BC1# and BC2#≧ Vcc - 0.2V	~ +70°C	-	-	15	μA
		S1 $\leq$ 0.2V, S2 $\geq$ Vcc - 0.2V other inputs = 0 ~ Vcc	~ +85°C	-	-	30	
lcc4	Stand by supply current ( AC.TTL level )	BC1# and BC2#=VIH or S1#=VIH or S2= Other inputs= 0 ~ Vcc	VIL	-	-	0.5	mA

\* -0.7V in case of AC (Pulse width  $\leq$  30ns)

Note 3: Direction for current flowing into IC is indicated as positive (no mark)

Note 4: Typical parameter indicates the value for the center of distribution at 2.3V, and not 100% tested.

#### CAPACITANCE

(Vcc=1.65 ~ 2.3V, unless otherwise noted)

Svmbo	Parameter	Conditions		Limits		
Symbol Parameter	Conditions	Min	Тур	Max	Units	
Cı	Input capacitance	VI=GND, VI=25mVrms, f=1MHz			10	рF
Co	Output capacitance	Vo=GND,Vo=25mVrms, f=1MHz	10		P۳	



#### AC ELECTRICAL CHARACTERISTICS (Vcc=1.65 ~ 2.3V, unless otherwise noted) (1) TEST CONDITIONS

- 2			_
	Supply voltage	1.65~2.3V	1TTL
	Input pulse	VIH=0.7 x Vcc+0.2V, VIL=0.2V	
	Input rise time and fall time	5ns	
	Reference level	VoH=VoL=0.9V Transition is measured ±200mV from steady state voltage.(for ten,tdis)	
		Fig.1,CL=30pF	Including scope and
	Output loads	CL=5pF (for ten,tdis)	jig capacitance
$\overline{0}$			Fig.1 Output load

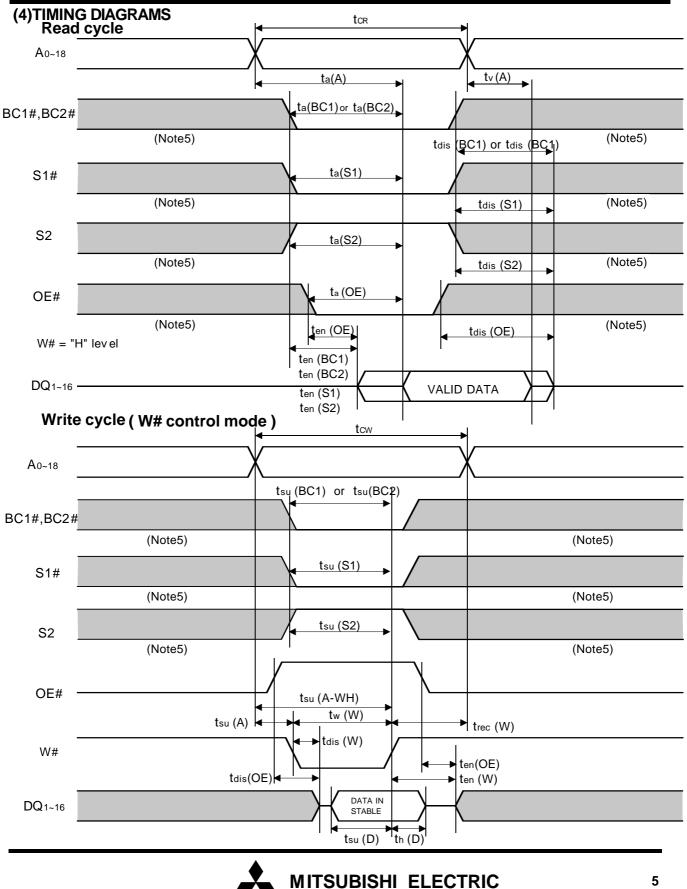
### (2) READ CYCLE

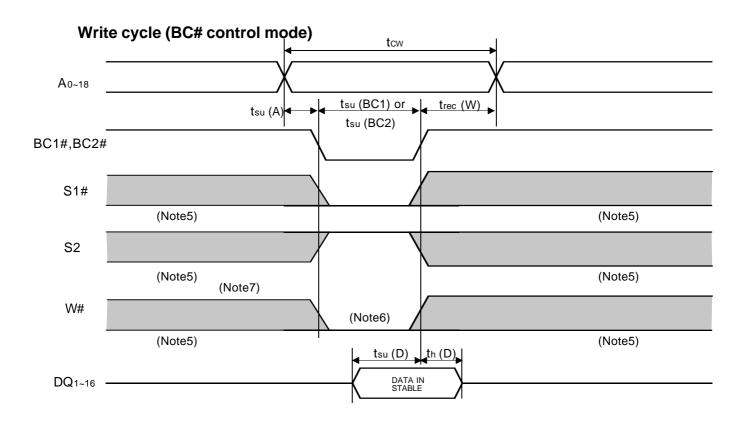
				Lim	its			
Symbol	Parameter	55	HI	70HI		85HI		Units
,		Min	Max	Min	Max	Min	Max	
tcr	Read cycle time	55		70		85		ns
ta(A)	Address access time		55		70		85	ns
ta(S1)	Chip select 1 access time		55		70		85	ns
ta(S2)	Chip select 2 access time		55		70		85	ns
ta(BC1)	Byte control 1 access time		55		70		85	ns
ta(BC2)	Byte control 2 access time		55		70		85	ns
ta(OE)	Output enable access time		30		35		45	ns
tdis(S1)	Output disable time after S1# high		20		25		30	ns
tdis(S2)	Output disable time after S2 low		20		25		30	ns
tdis(BC1)	Output disable time after BC1# high		20		25		30	ns
tdis(BC2)	Output disable time after BC2# high		20		25		30	ns
tdis(OE)	Output disable time after OE# high		20		25		30	ns
ten(S1)	Output enable time after S1# low	5		10		10		ns
ten(S2)	Output enable time after S2 high	5		10		10		ns
ten(BC1)	Output enable time after BC1# low	5		5		5		ns
ten(BC2)	Output enable time after BC2# low	5		5		5		ns
ten(OE)	Output enable time after OE# low	5		5		5		ns
t∨(A)	Data valid time after address	5		10		10		ns

#### (3) WRITE CYCLE

				Lim	its	_		
Symbol	Parameter	55	HI	70	HI	85	δHI	Units
,		Min	Max	Min	Мах	Min	Max	
tcw	Write cycle time	55		70		85		ns
t <sub>w</sub> (W)	Write pulse width	45		55		60		ns
tsu(A)	Address setup time	0		0		0		ns
tsu(A-WH)	Address setup time with respect to W#	50		65		70		ns
tsu(BC1)	Byte control 1 setup time	50		65		70		ns
tsu(BC2)	Byte control 2 setup time	50		65		70		ns
t <sub>su</sub> (S1)	Chip select 1 setup time	50		65		70		ns
tsu(S2)	Chip select 2 setup time	50		65		70		ns
t <sub>su</sub> (D)	Data setup time	25		30		35		ns
th(D)	Data hold time	0		0		0		ns
trec(W)	Write recovery time	0		0		0		ns
tdis(W)	Output disable time from W# low		20		25		30	ns
tdis(OE)	Output disable time from OE# high		20		25		30	ns
ten(W)	Output enable time from W# high	5		5		5		ns
ten(OE)	Output enable time from OE# low	5		5		5		ns







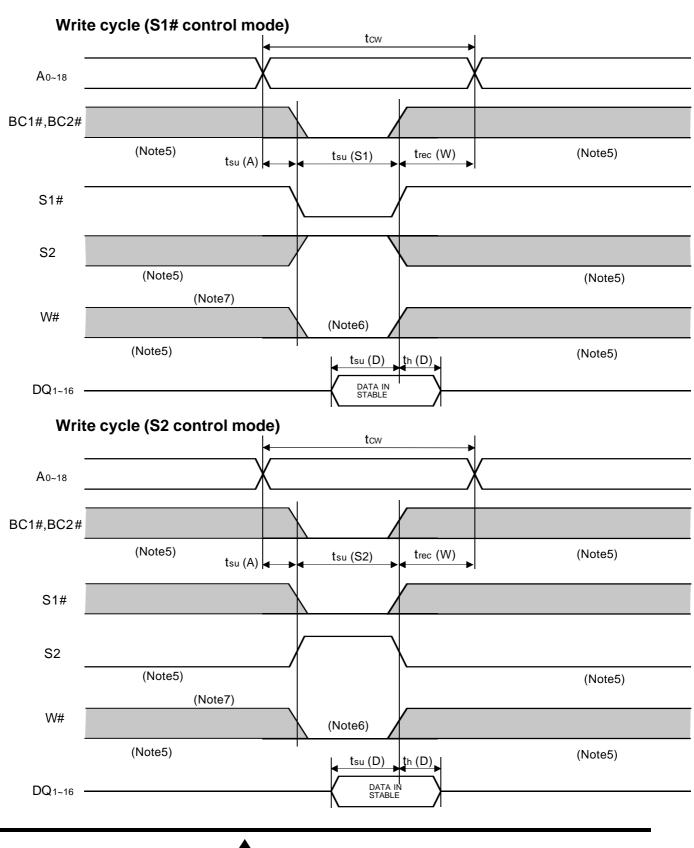
Note 5: Hatching indicates the state is "don't care".

Note 6: A Write occurs during S1# low, S2 high ov erlaps BC1# and/or BC2# low and W# low.

Note 7: When the falling edge of W# is simultaneously or prior to the falling edge of BC1# and/or BC2# or the falling edge of S1# or rising edge of S2, the outputs are maintained in the high impedance state.

Note 8: Don't apply inverted phase signal externally when DQ pin is in output mode.





MITSUBISHI ELECTRIC

7

# M5M5Y816WG -55HI, -70HI, -85HI

#### 8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM

#### POWER DOWN CHARACTERISTICS (1) ELECTRICAL CHARACTERISTICS

<u> </u>	<b>D</b> (	<b>—</b>			Limits		
Symbol	Parameter	Test condition	conditions		Тур	Max	Units
Vcc (PD)	Power down supply voltage			1.3			V
VI (BC)	Byte control input BC1# &	1.65V≦ Vcc(PD)		0.7xVcc			
VI (BC)	BC2#	1.3V ≦ Vcc(PD)≦1.65V			Vcc(PD)		V
VI (S1) Chip select input S1#	1.65V <u>≤</u> Vcc(PD)		0.7xVcc				
	Chip select input S1#	1.3V ≦ Vcc(PD)≦1.65V			Vcc(PD)		V
VI (S2)	Chip select input S2					0.2	V
	Power down supply current	Vcc=1.65V (1) S1# $\geq$ Vcc - 0.2V,	~ +25°C	-	0.1	1	
Icc (PD)		other inputs = $0 \sim Vcc$ (2) S2 $\leq 0.2V$ ,	~ +40°C	-	0.2	2	
		other inputs = 0 ~ Vcc (3) BC1# and BC2#≧ Vcc - 0.2V	~ +70°C	-	-	8	μA
		S1# $\leq$ 0.2V, S2 $\geq$ Vcc - 0.2V other inputs = 0 ~ Vcc	~ +85°C	-	-	15	

#### (2) TIMING REQUIREMENTS

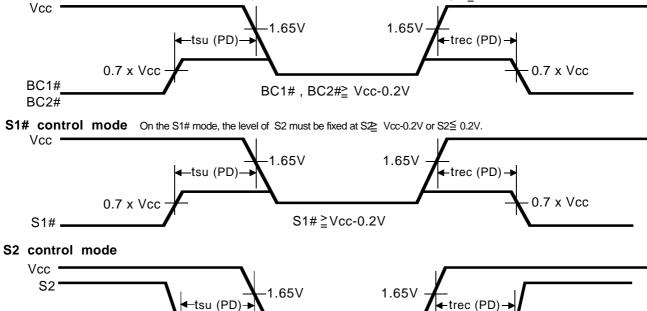
0.2V

Note 9: Typical parameter of Icc(PD) indicates the value for the center of distribution at 1.65V, and not 100% tested.

				Limite	5	
Symbol	Parameter	Test conditions	Min	Тур	Max	Units
tsu (PD)	Power down set up time		0			ns
trec (PD)	Power down recovery time		5			ms

## (3) TIMING DIAGRAM

BC# control mode On the BC# control mode, the level of S1# and S2 must be fixed at S1#, S2≧ Vcc-0.2V or S2≦0.2V





S2 ≦ 0.2V

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